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-	115529	(stub skeleton)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:29
-	546	((stub skeleton)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:29
-	32	(stub and skeleton) same log\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:29
-	1164	(stub skeleton) same log\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:30
-	62	((stub skeleton) same log\$4) and (((stub skeleton)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:29
-	1164	stub same log\$4) (skeleton same log\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:30
-	1164	stub same log\$4) (skeleton same log\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:31
-	1164	(stub same log\$4) or (skeleton same log\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:31
-	62	((stub same log\$4) or (skeleton same log\$4)) and (((stub skeleton)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:31
-	622	(stub near30 log\$4) or (skeleton near30 log\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:32
-	22	((stub near30 log\$4) or (skeleton near30 log\$4)) and (((stub skeleton)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:32
-	2240	(stub near30 (log\$4 trac\$3)) or (skeleton near30 (log\$4 trac\$3))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 10:33

-	34	((stub near30 (log\$4 trac\$3)) or (skeleton near30 (log\$4 trac\$3))) and (((stub skeleton)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 14:01
-	0	98123890.0	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 14:01
-	0	"98123890"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 14:01
-	10	"924615"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/21 14:33
-	49	("6002872" "6158024" "6336118" "6637020" "5339435" "6122675" "5964839" "6467052" "6083281" "5612898" "5611044" "5799143" "6047390" "5594892" "5740408" "6006032" "6081900" "6519568" "6189142" "5450586" "6279030" "6236999" "6385643" "6425017" "6571274" "6581088" "5682328" "5781778" "5794046" "6028999" "6266666" "6219619" "6219619" "6442488" "5565316" "5827070" "6363391" "6389379" "5253359" "4949278" "5530848" "5721912" "5778060" "6353446" "6671829" "6671830" "6691254" "6708293" "4758956" "4398272").pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT	2004/05/21 15:13
-	668	instrument\$5 and stub and log\$3	USPAT	2004/05/21 15:13

-	42	instrument\$5 and (stub and skeleton) and log\$3	USPAT	2004/05/21 15:15
-	41	instrument\$5 and (stub and skeleton) and (log logging)	USPAT	2004/05/21 15:17
-	45	instrument\$5 and (stub and skeleton) and (log logging trace filter)	USPAT	2004/05/21 15:17
-	4	(instrument\$5 and (stub and skeleton) and (log logging trace filter)) not (instrument\$5 and (stub and skeleton) and (log logging))	USPAT	2004/05/21 15:17
-	1391	regular adj expression	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/24 14:36
-	82	(regular adj expression) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/24 14:36
-	2251	enable near4 (log or logging)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 07:58
-	37	(enable near4 (log or logging)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 07:34
-	3	stub near4 enable near4 (log or logging)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:01
-	5273	instrument\$5 near4 parameter	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:02
-	27	(((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.) and (instrument\$5 near4 parameter)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:02
-	0	(instrument\$5 near4 (additional or extra or added) near4 parameter) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:03
-	0	instrument\$5 near4 (additional or extra or added) near4 parameter and 717.clas.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:03
-	54	instrument\$5 near4 (additional or extra or added) near4 parameter	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:04
-	54	instrument\$5 near4 (additional or extra or added) near4 (parameter or argument)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 08:08
-	4	((("6186677") or ("5987249")).PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/05/25 09:03

-	15130	additional near4 parameter	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 09:03
-	175	((additional near4 parameter) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 09:03
-	19	additional near4 parameter same stub	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 11:38
-	547	cpu near4 (log or logging)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 11:38
-	2689	(cpu processor) near4 (log logging)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 11:38
-	6329	((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 11:39
-	32640	((cpu processor) near4 (log logging)) an (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 11:39
-	46	((cpu processor) near4 (log logging)) and (((717/124,126-128,130-133,136,140,151,154-158) or (719/313,315,317,319,328,330) or (709/201,202)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/25 11:39

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M. Harkema, D. Quartel, B. M. M. Gijsen, R. D. van der Mei

 July 2002 **Proceedings of the third international workshop on Software and performance**

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Over the past few years, Java has evolved into a mature platform for developing enterprise applications. A critical factor for the commercial success of these applications is end-to-end performance, e.g., in terms of response times, throughput and availability. This raises the need for the development, validation and analysis of performance models to predict performance metrics of interest. To develop and validate performance models, insight in the execution behavior of the application is essent ...

Keywords: performance measurement and monitoring of java applications

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Malcolm Atkinson, Mick Jordan

November 1996 Technical Report, Sun Microsystems, Inc.

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These proceedings record the First International Workshop on Persistence and Java, which was held in Drymen, Scotland in September 1996. The focus of this workshop was the relationship between the Java languages and long-term data storage, such as databases and orthogonal persistence. There are many approaches being taken, some pragmatic and some guided by design principles. If future application programmers building large and long-lived systems are to be well-supported, it is essential that the ...

3 [DECALS: distributed experiment control and logging system](#)

Alex Hubbard, C. Murray Woodside, Cheryl Schramm

 November 1995 **Proceedings of the 1995 conference of the Centre for Advanced Studies on Collaborative research**

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In developing distributed applications and services there is a need to be able to set up and run tests on a set of processes. The experiment might be to obtain performance data, to test the processes' behaviour, or to evaluate an application management strategy. Common requirements are • to load and run special versions of at least some of the software, often on multiple nodes of a network, • to initialize the software in a well-controlled way, so the tests may be repeatable, • ...


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Uzawa, Y.; Wang, Z.; Kawakami, A.;

Applied Superconductivity, IEEE Transactions on , Volume: 7 , Issue: 2 , June 1997

Pages:2574 - 2577

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2 Evaluation of integrated tuning elements with SIS devices
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Microwave Theory and Techniques, IEEE Transactions on , Volume: 41 , Issue: 4 , April 1993

Pages:605 - 608

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3 A multiradius, reciprocal implementation of the thin-wire moment method
Tilston, M.A.; Balmain, K.G.;

Antennas and Propagation, IEEE Transactions on , Volume: 38 , Issue: 10 , Oct. 1990

Pages:1636 - 1644

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4 MM wave quasioptical SIS mixers
Hu, Q.; Mears, C.A.; Richards, P.L.; Lloyd, F.L.;

Magnetism, IEEE Transactions on , Volume: 25 , Issue: 2 , Mar 1989

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Di-Luan Le; Ghannouchi, F.M.;

Instrumentation and Measurement, IEEE Transactions on , Volume: 44 , Issue: 4 , Aug. 1995
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2 Modeling, simulation, and measurement considerations of high-speed digital buses

Novak, I.;

Instrumentation and Measurement, IEEE Transactions on , Volume: 41 , Issue: 6 , Dec. 1992
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Novak, I.;

Instrumentation and Measurement Technology Conference, 1992. IMTC '92., 9th IEEE , 12-14 May 1992
Pages:147 - 151

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4 The Level-2 muon trigger at D0

Fortner, M.; Maciel, A.; Evans, H.; Kothari, B.; Uzunyan, S.;

Nuclear Science, IEEE Transactions on , Volume: 49 , Issue: 4 , Aug. 2002
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